



Parameter Correlations in the ECLLOUD Simulation for the Cloud Lifetime Study Using SPU Witness Bunch Data, First Results for Carbon-coated Vacuum Chambers and

First Results Using SYNRAD3D Azimuthal Photoelectron Distributions

All material for this talk may be obtained at www.lepp.cornell.edu/~critten/cesrta/ecloud/24nov10

See also previous talks on simulations for the shielded pickup data on 4/21, 4/28, 5/12, 7/7, 7/14, 8/4, 9/8, 9/22, and 11/3/2010

A primary purpose of the shielded pickup project (time-resolved measurements) is to measure the cloud lifetime.

This lifetime is sensitive to the secondary yield for low-energy cloud particles hitting the vacuum chamber wall.

First results on the sensitivity to the parameter δ_0 using witness bunch data were shown on 9/22/2010 and at ECLLOUD10.

In the meantime, the ECLLOUD SPU acceptance model has been improved and hole secondaries introduced (3 Nov).

Today we address the systematic sensitivity of the δ_0 determination to other model parameters.

Motivated by Joe Calvey's RFA studies of model parameters shown last week, we use the data for carbon-coated vacuum chambers for this purpose. We also show the first use of the SYNRAD3D fits for photoelectron azimuthal distributions.

Jim Crittenden

Cornell Laboratory for Accelerator-Based Sciences and Education

Electron Cloud Meeting

24 November 2010





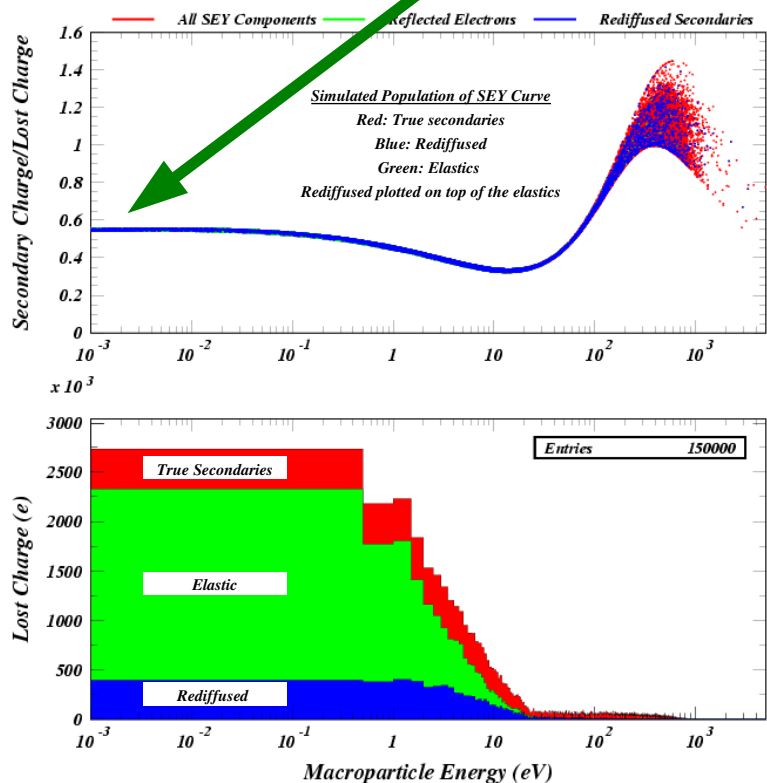
Secondary Yield Model

True secondary yield: 0.9

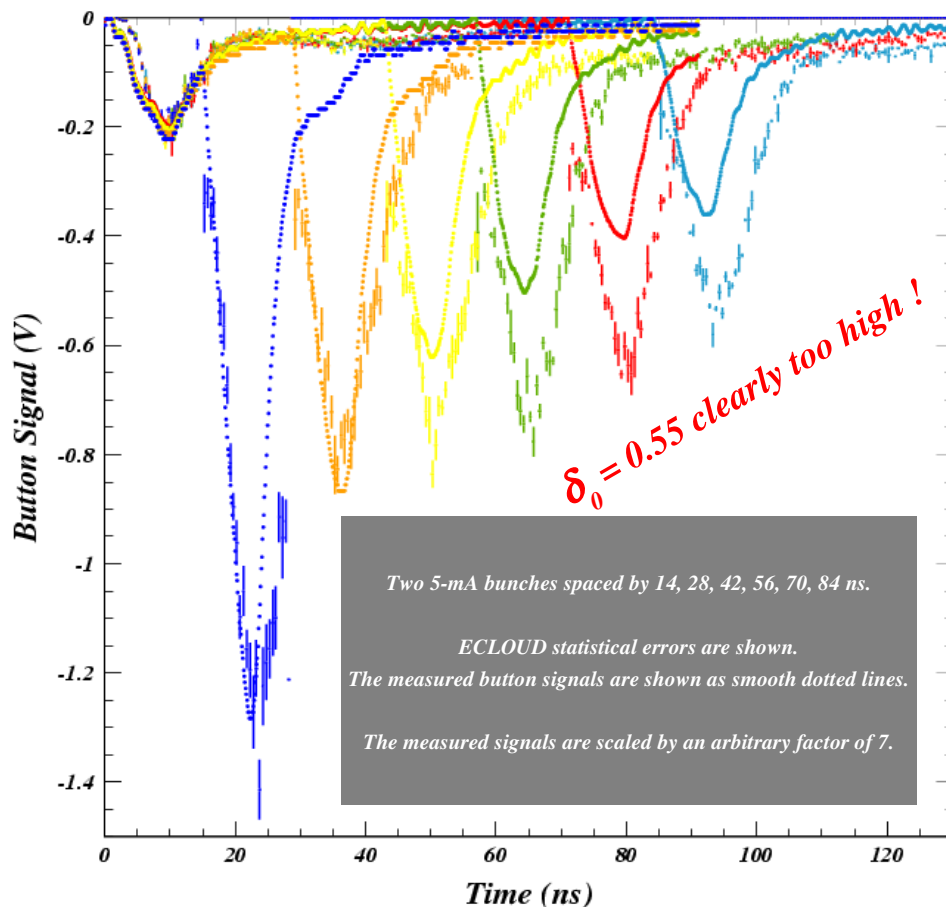
True secondary peak energy: 400 eV

Rediffused yield: 0.1

Elastic yield $\delta_0: 0.55$

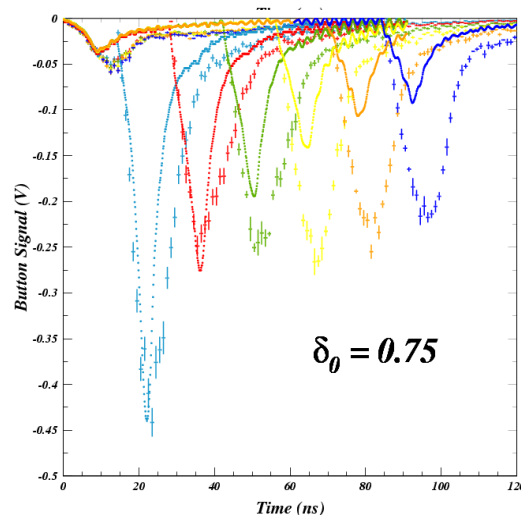
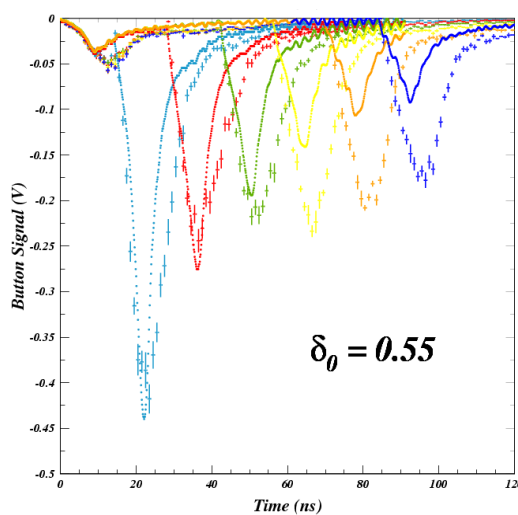
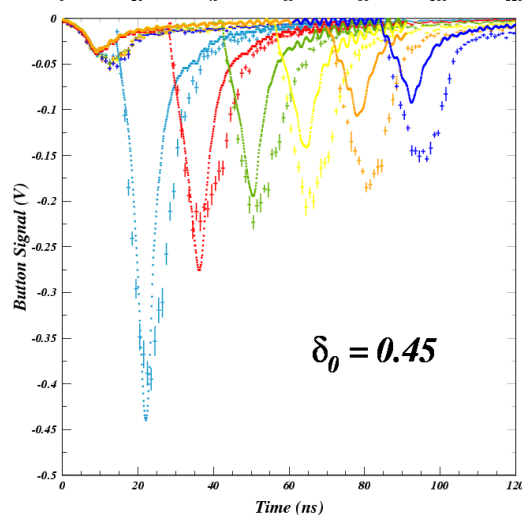
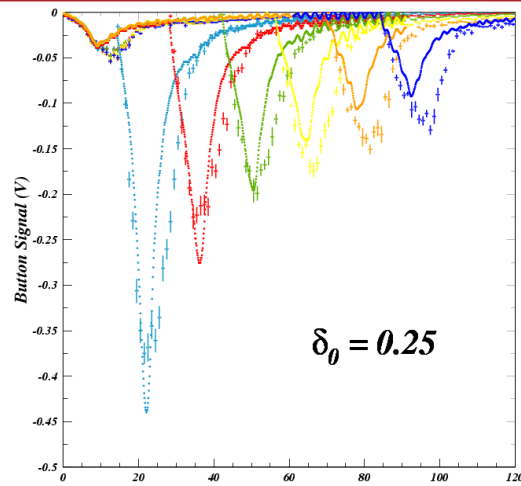
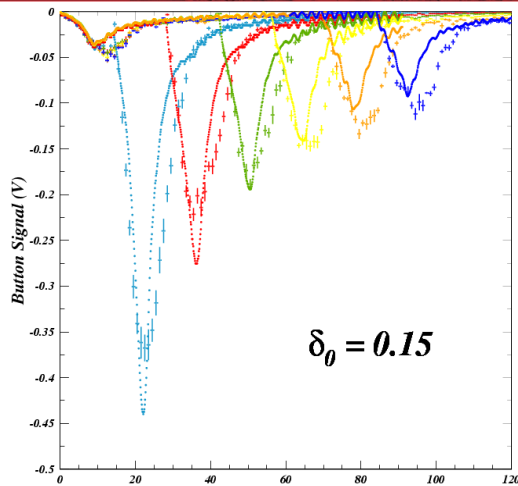
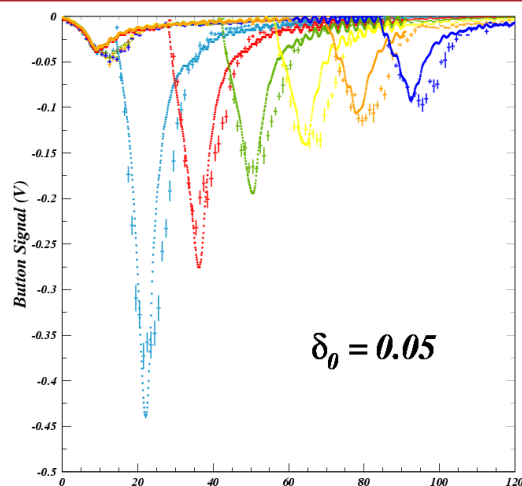


Cloud Lifetime Study with $\delta_0 = 0.55$



Simulated cloud lifetime found to be sensitive to δ_0

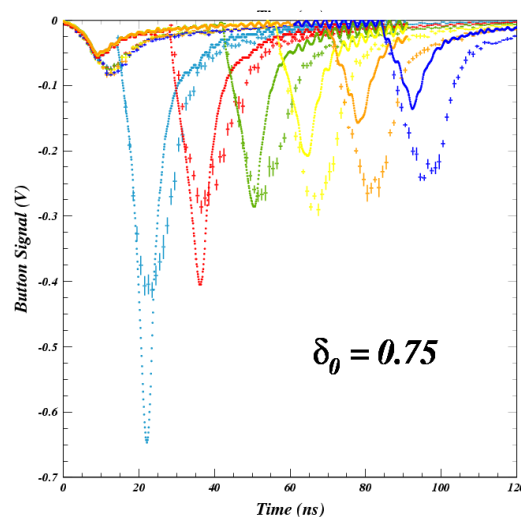
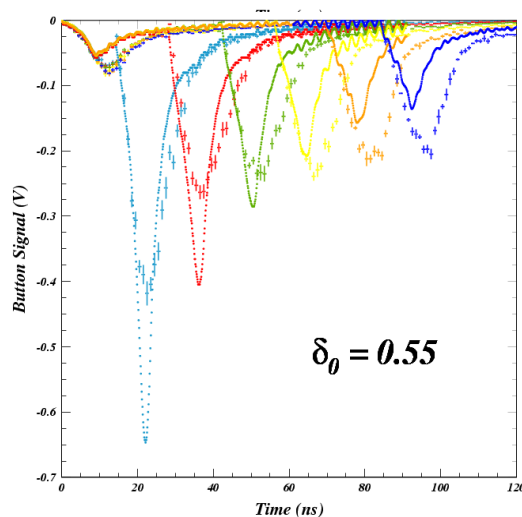
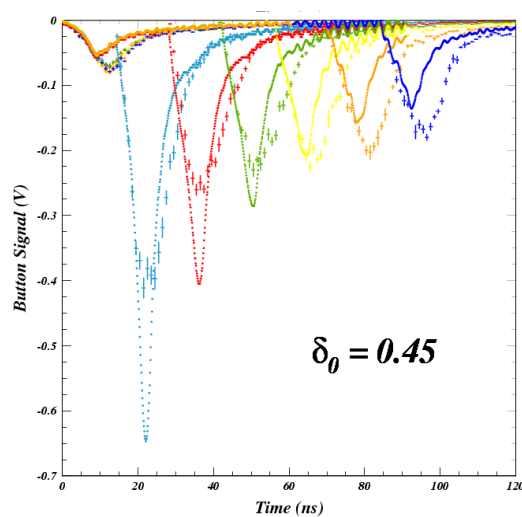
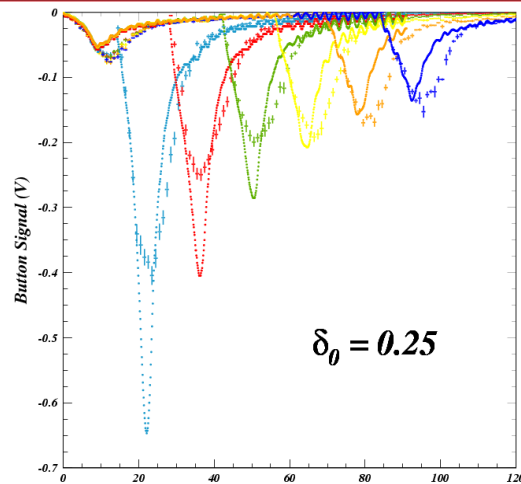
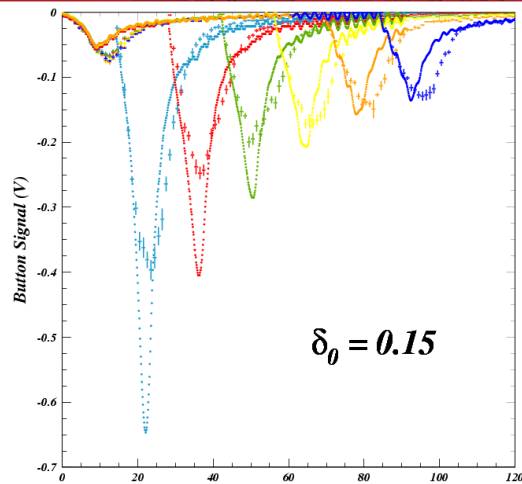
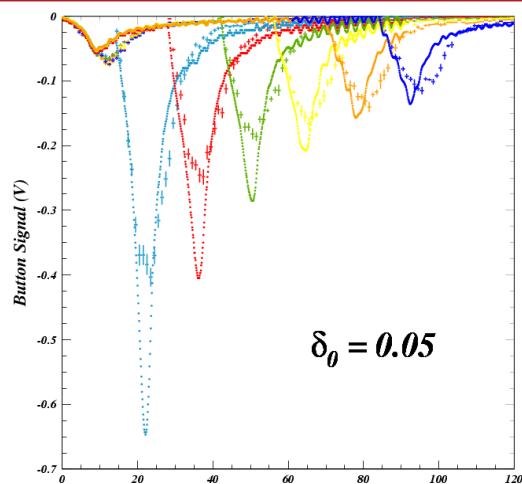
TiN (3/27 15E 14-ns) : $\delta_0 = 0.05$ Al(5/17 15W 4-ns): $\delta_0 = 0.75$



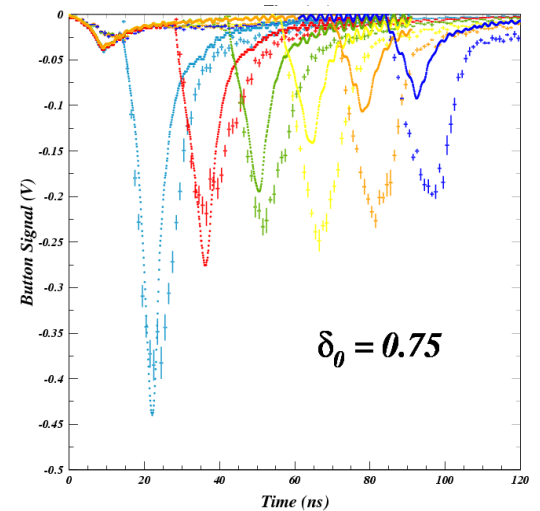
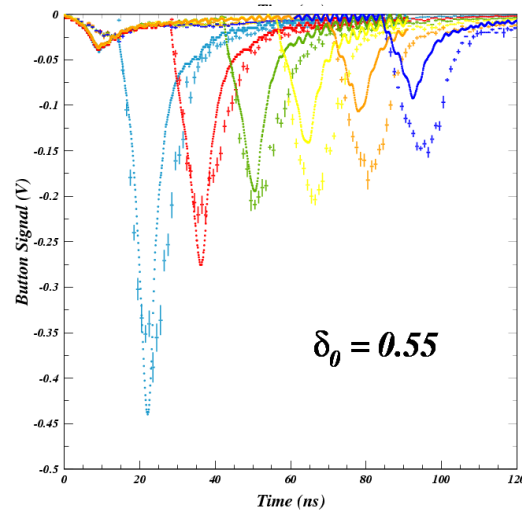
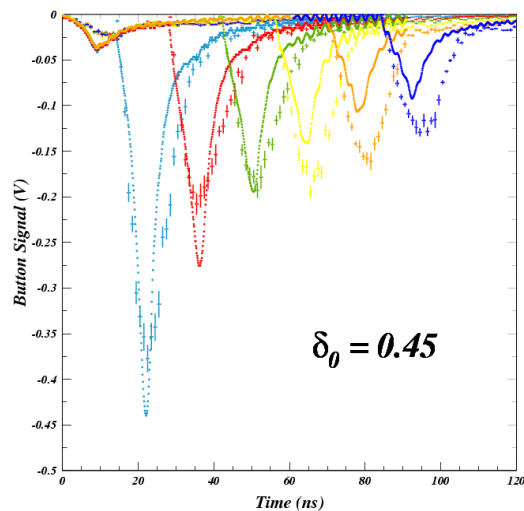
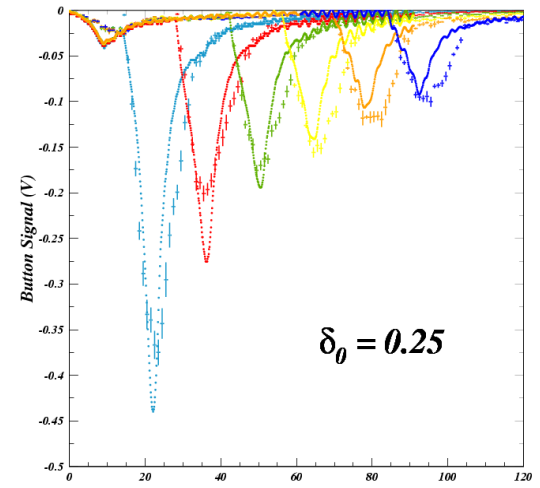
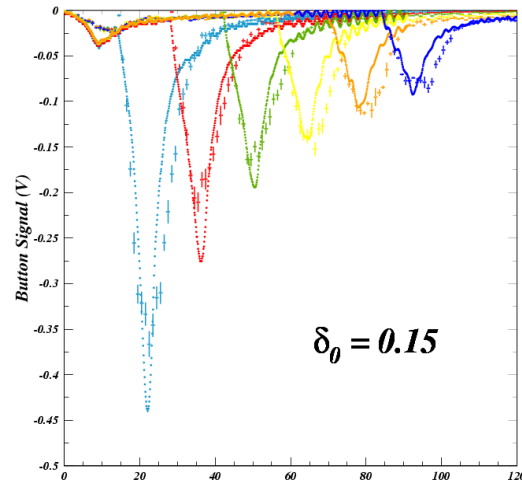
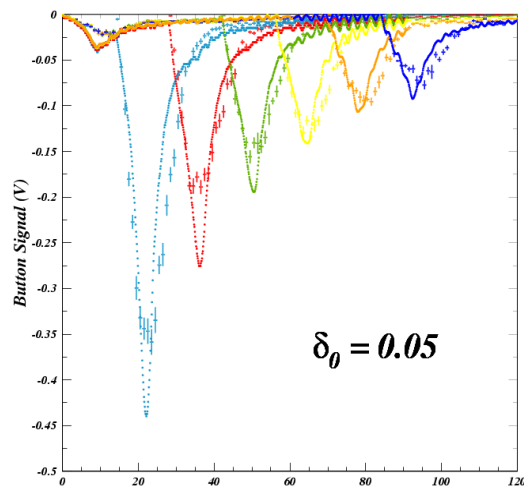
Baseline parameters: 0.9 γ /m/s, q.e. 5%, reflectivity 20%, $\delta_{ts} = 0.7$, $E_{pk} = 400$ eV, $\delta_{red} = 0.1$.

SPU signal scaled by factor 1.7.

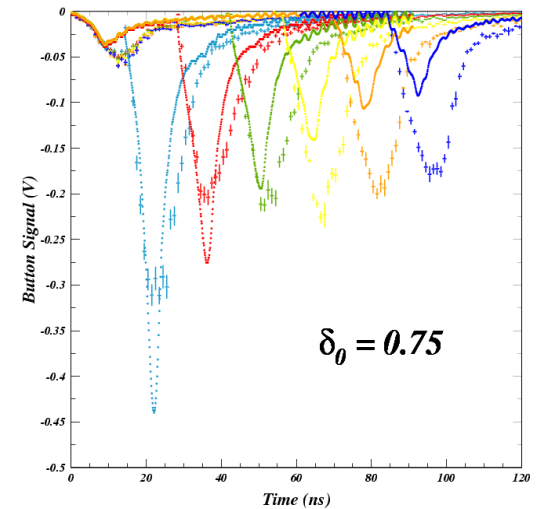
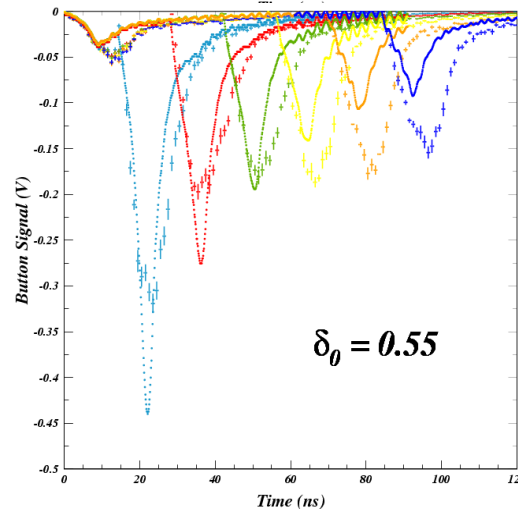
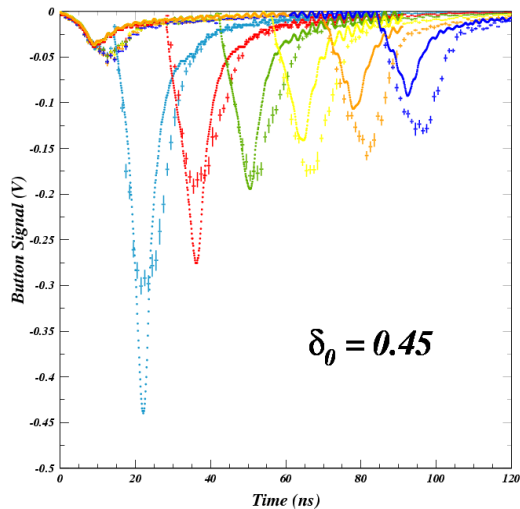
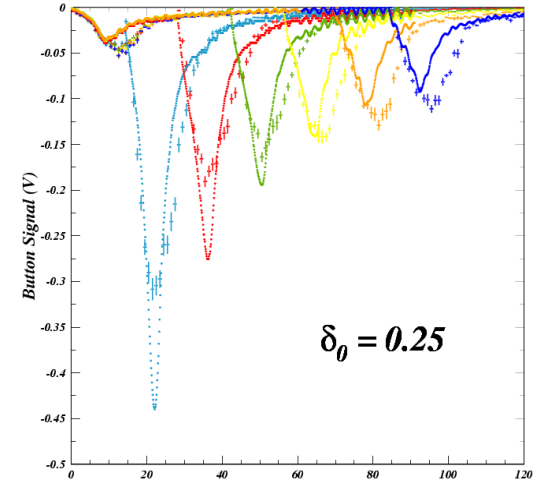
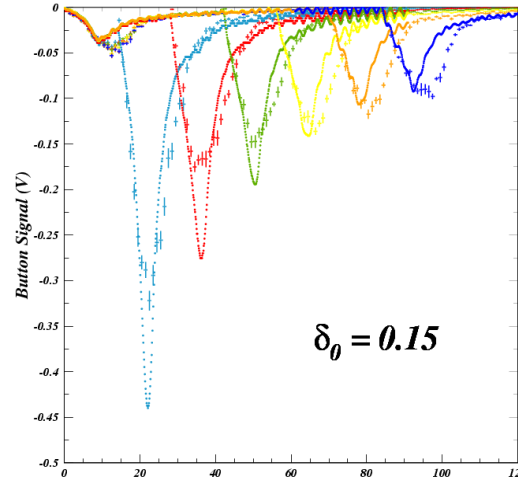
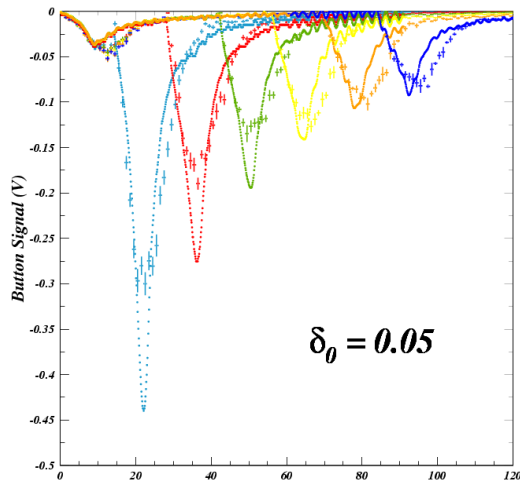
Elastic yield parameter $\delta_0 = 0.05$ is the best match.



The source of the rising edge of the first-bunch signal is photoelectrons from the bottom of the beampipe, so the SPU scale factor must be raised from 1.7 to 2.5. No value for δ_0 reproduces the measured witness bunch signals.



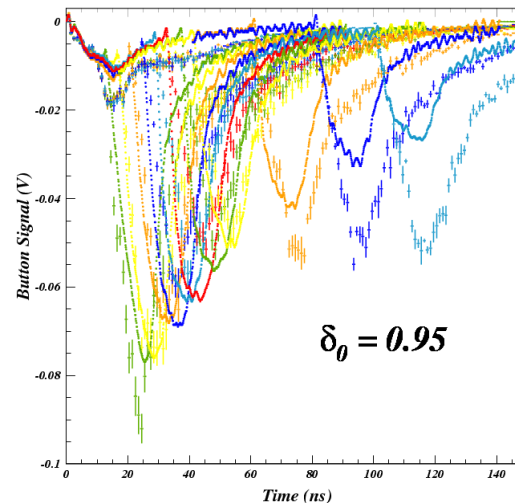
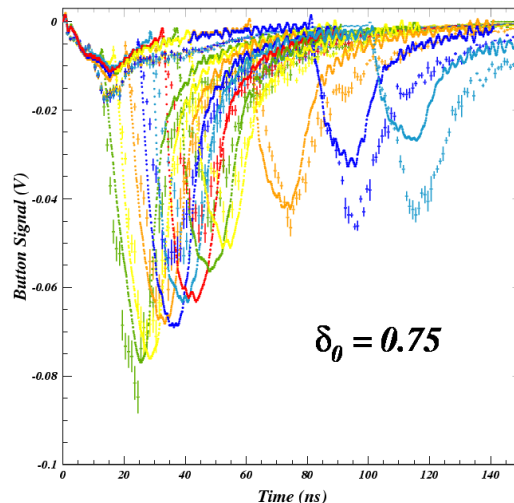
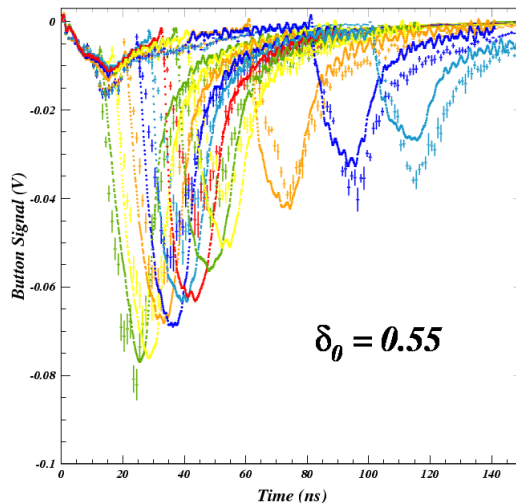
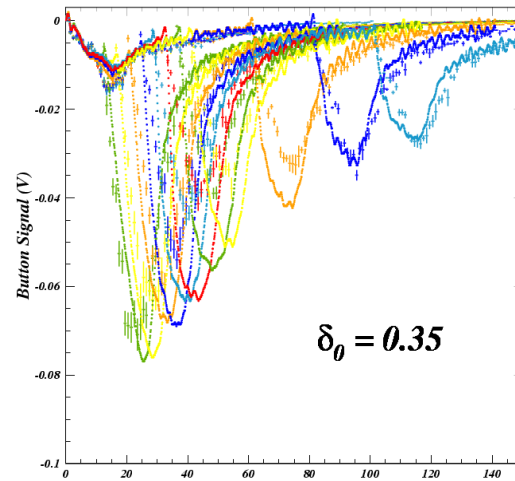
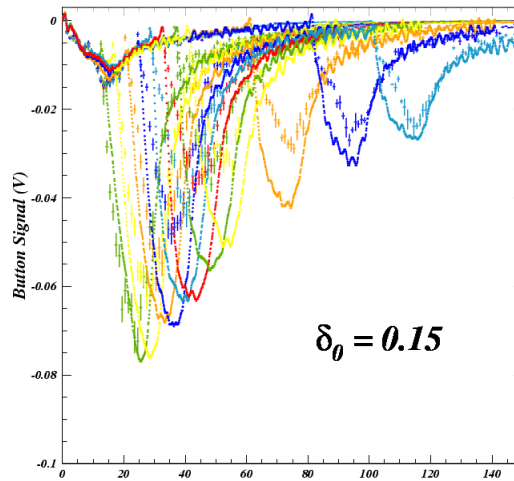
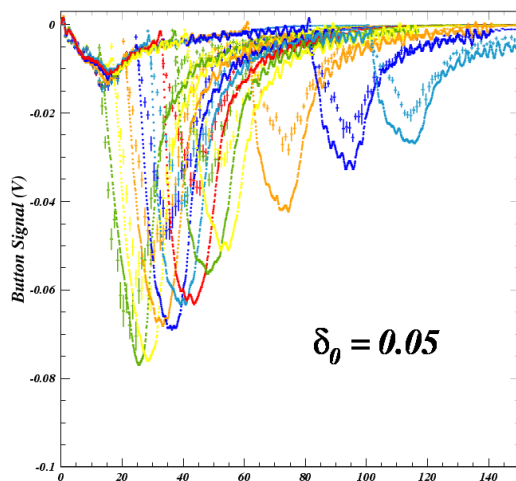
For this comparison, the SPU scale factor has been left unchanged at 1.7, rather than reducing it to 0.85. The simulated ratio of the 4-ns-bunch signal to that of the first-bunch is clearly wrong. If this were corrected, again, no value for δ_0 would reproduce the measured witness bunch signals, because the direct signal contributes a substantial fraction of the 84-ns-bunch signal.



Nope. The elastic component does not contribute enough to the 4-ns-bunch signal to compensate a deficit in the true secondary yield.

Also investigated $E_{pk} = 250, 400$ eV, $\delta_{ts} = 0.9$, $\delta_{red} = 0.1, 0.3$ and δ_{ts} , δ_{red} correlation. The elastic yield did not budge.

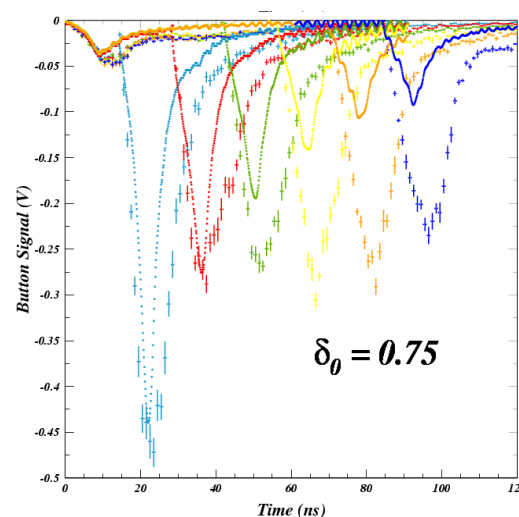
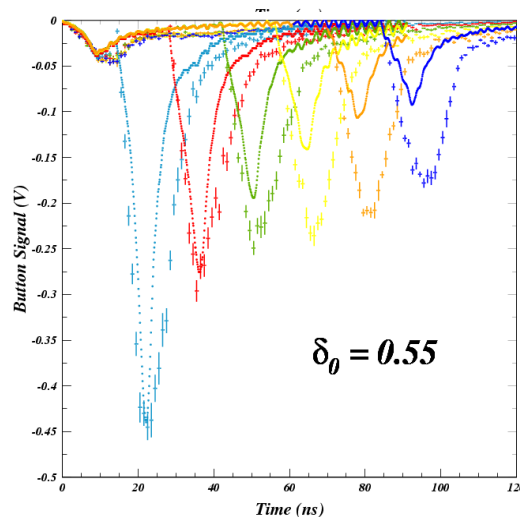
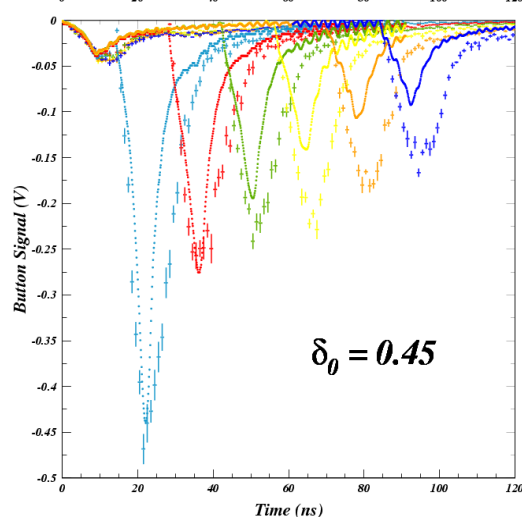
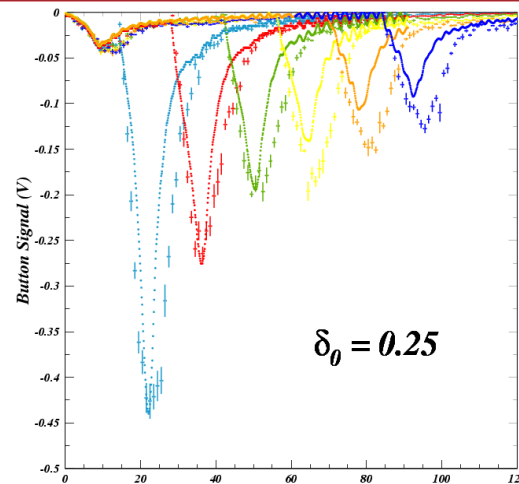
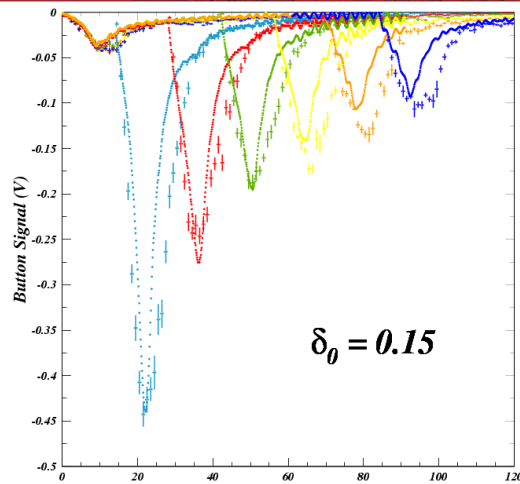
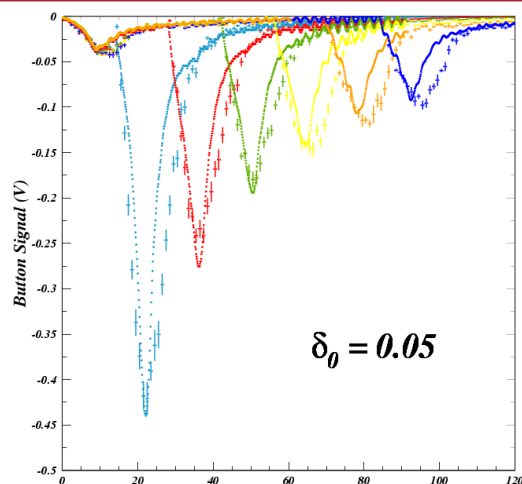
Also, none of these parameters could explain the narrowness of the observed signals. Needs more study.



Baseline parameters: 0.4 γ /m/s, q.e. 5%, reflectivity 40%, $\delta_{ts} = 0.7$, $E_{pk} = 400$ eV, $\delta_{red} = 0.1$.

SPU signal scaled by factor 1.4.

Elastic yield parameter $\delta_0 = 0.35$ is the best match, but work needed.



3/27 15W 5 mA
14-ns spacing

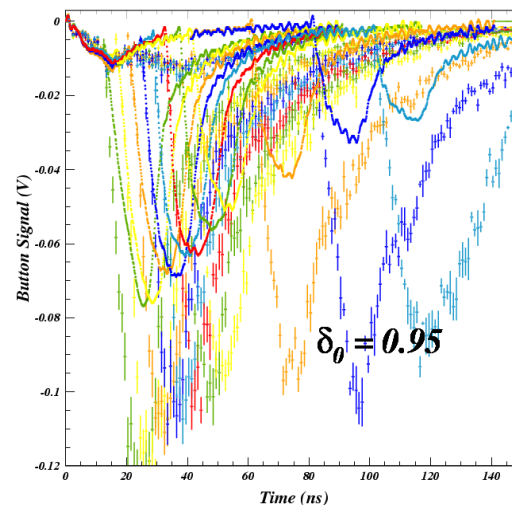
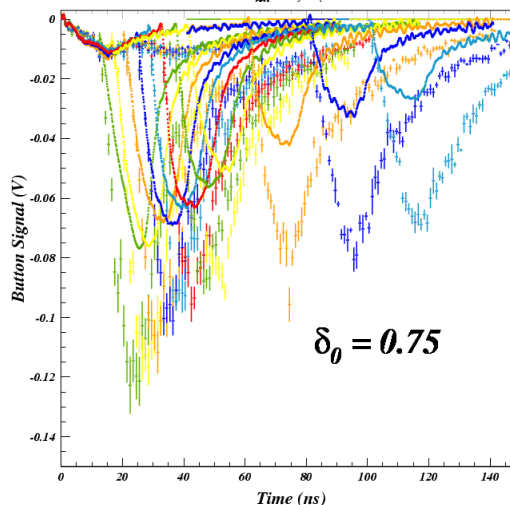
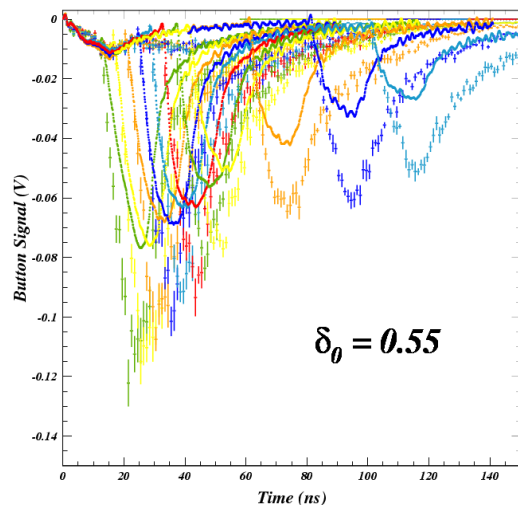
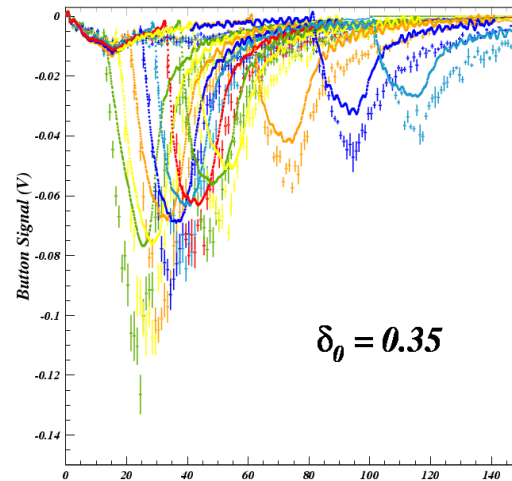
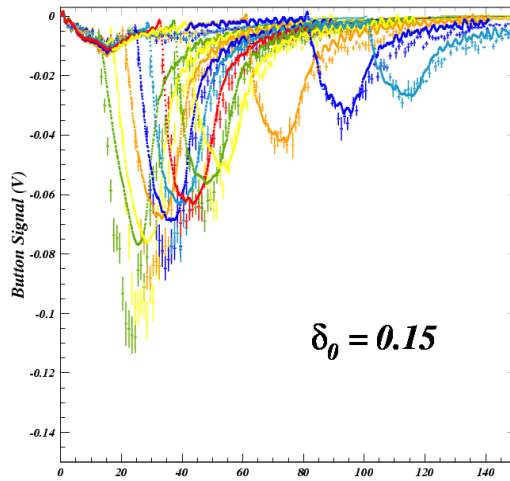
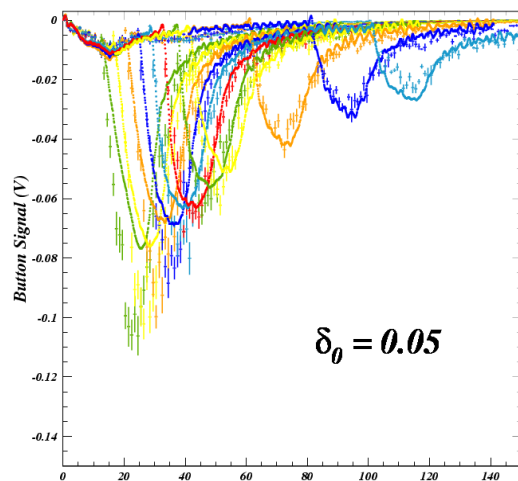
q.e. 10%
spu scale 1.7
unchanged

Remarkable
agreement!

SYNRAD3D provides absolute photon rates as a function of scaled v.c. perimeter in the form of six Lorentzian fit parameters.

https://wiki.lepp.cornell.edu/ilc/pub/Public/CesrTA/EcloudParams/Synrad3d_RFA_fits.pdf

ECLOUD reads the csv file and generates the azimuthal distribution using Miguel's ellipse functions and my Monte Carlo utilities.



3/17 15E 3 mA
4-ns spacing

q.e. 10%
spu scale 1.4
unchanged

Remarkable
agreement
again!

Lowering the
true
secondary
yield
below 0.7
may help.

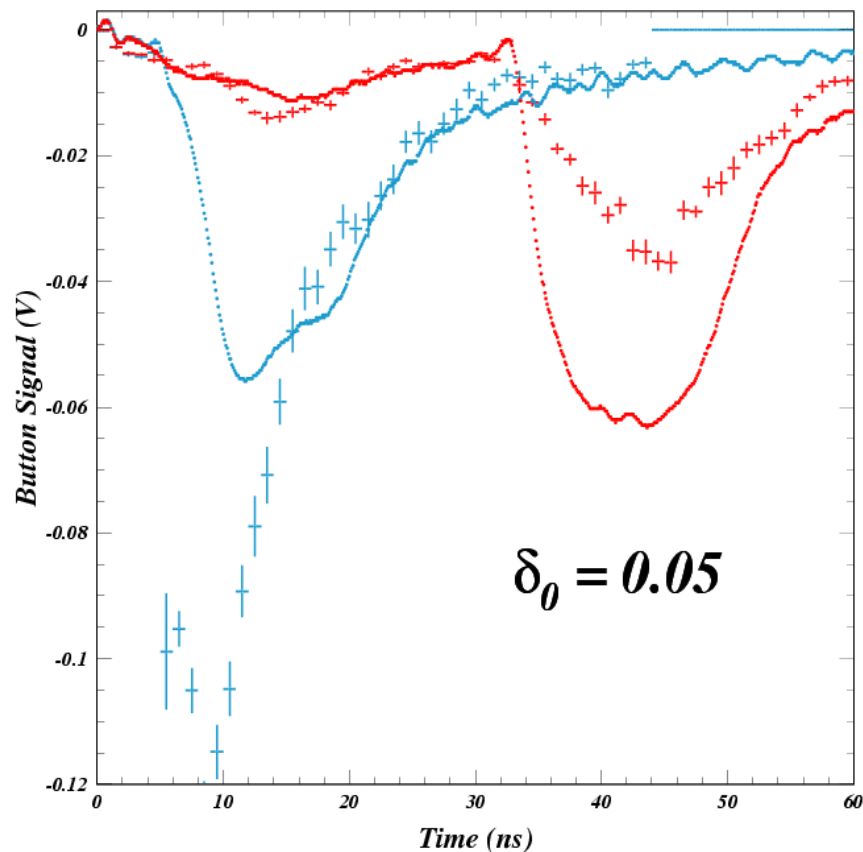
SYNRAD3D reproduces the WIDTH of the SPU signals better than the assumption of uniform azimuthal distribution of reflected photons.

Note that in each of these measurements, the positron beam was displaced 12 mm toward the outside of the vacuum chamber.

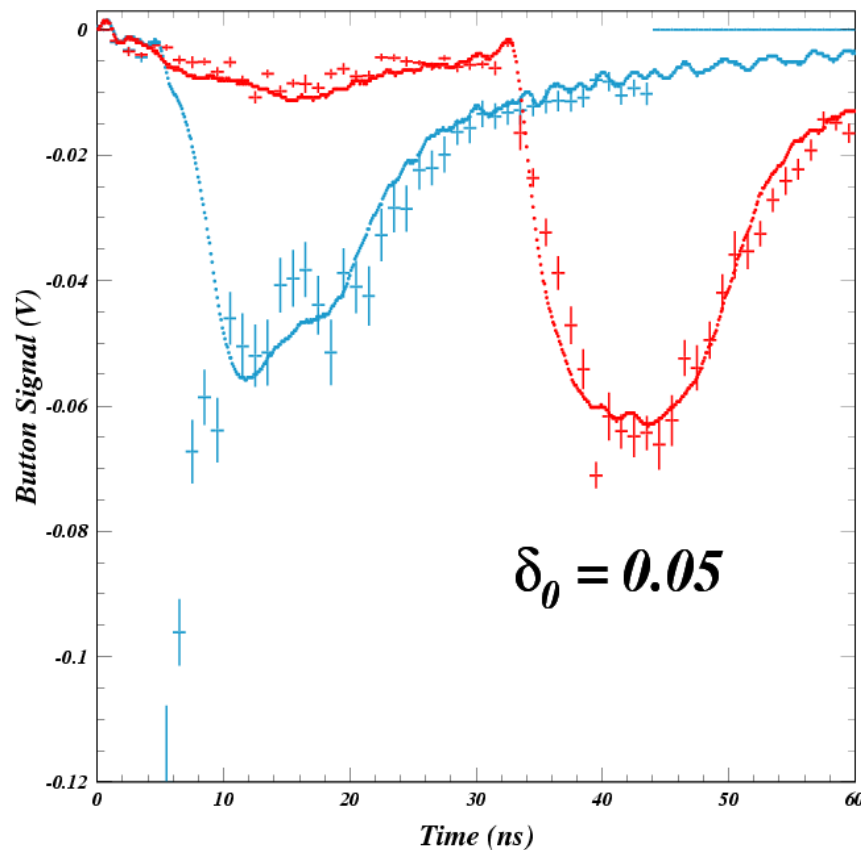
I continue to work on the excess early peak for closely spaced witness bunches, which is so bad that I omitted the 4-ns and 8-ns bunches here.



Uniform



SYNRAD3D

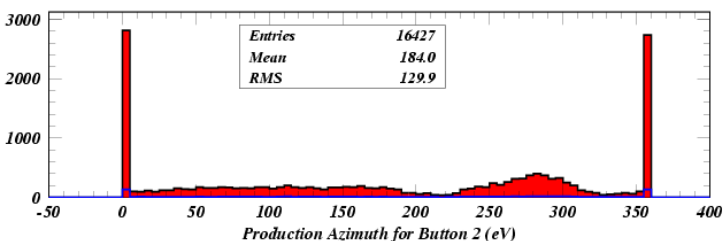
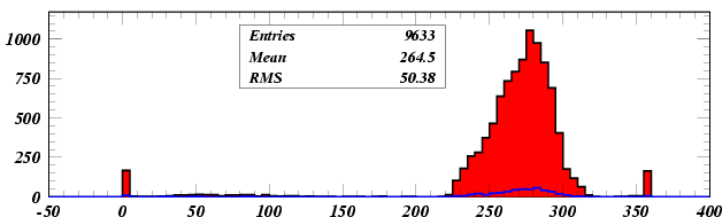
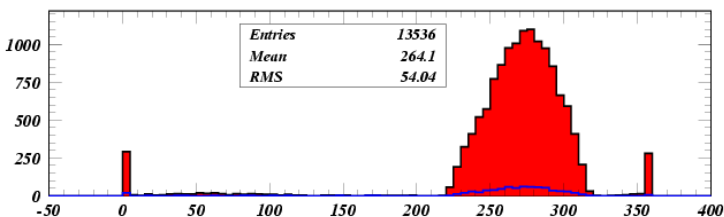


The SYNRAD3D azimuthal distribution is a remarkable improvement, both for the shape of the single-bunch signal and for the shapes and relative sizes of the witness bunches at 4 and 32 ns.

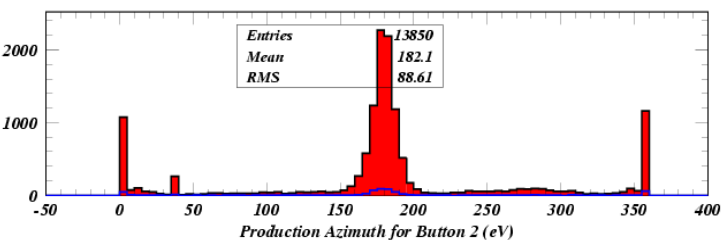
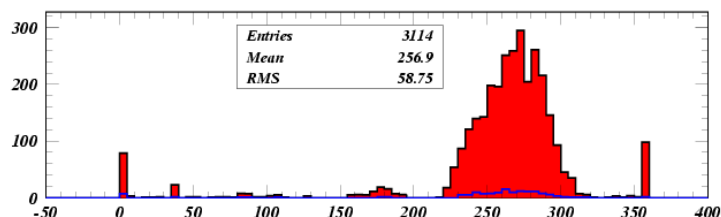
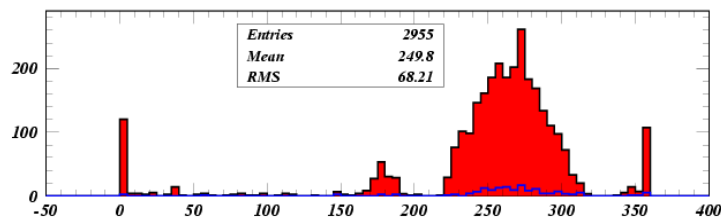
This explains why my weeks-long attempt to fix the 4-ns bunch with the photoelectron energy distribution alone has been so fruitless. The accuracy of the normalization must be fortuitous, since the assumption of 10% quantum efficiency for SYNRAD3D was arbitrary.



Uniform



SYNRAD3D



Single Bunch
 $0 < t < 30$ ns

4-ns Bunch
 $10 < t < 30$ ns

32-ns Bunch
 $32 < t < 52$ ns

Particles contributing to the signal by
producing secondaries in the port holes
are shown in blue

There are many fewer signal particles in SYNRAD3D for the first bunch and the witness bunch at 4-ns.
That is, SYNRAD3D produces many more particles at azimuthal positions where they cannot contribute to these signals.
Particles produced at the opposite side of the vacuum chamber from the primary source point are important for the
signal from the witness bunch at 32-ns. These are absent in the uniform azimuthal distribution.